

Features

- $R_{DS(ON)} \leq 150m\Omega @ V_{GS} = 10V$
- Low gate charge

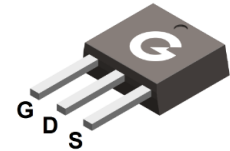
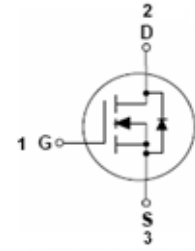
HF

Applications

- Networking DC-DC power system
- Load switch

Mechanical Data

- Case: TO-251
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208



TO-251

Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
BL10N10I	TO-251	80 pcs / Tube	10N10I

Maximum Ratings (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	100	V
Gate-to-Source Voltage	V_{GSS}	± 20	V
Continuous Drain Current ($T_C = 25^\circ\text{C}$) ^{*1}	I_D	10	A
Pulsed Drain Current ^{*2}	I_{DM}	40	A

Thermal Characteristics

Parameter	Symbol	Value	Unit
Power Dissipation ($T_C = 25^\circ\text{C}$) ^{*3}	P_D	27	W
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	4.6	$^\circ\text{C}/\text{W}$
Operating Junction Temperature Range	T_J	-55 ~ +150	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	-55 ~ +150	$^\circ\text{C}$

Electrical Characteristics (@ $T_J = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
V_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	100	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 100V, V_{GS} = 0V, T_J = 25^\circ\text{C}$	-	-	1	μA
		$V_{DS} = 100V, V_{GS} = 0V, T_J = 55^\circ\text{C}$	-	-	5	μA
I_{GSS}	Gate-Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	± 100	nA
On Characteristics						
$R_{DS(ON)}$	Static Drain-Source On-resistance ^{*2}	$V_{GS} = 10V, I_D = 10A$	-	135	150	m Ω
		$V_{GS} = 4.5V, I_D = 5A$	-	180	220	m Ω
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	1	-	2.5	V
Dynamic Characteristics						
C_{ISS}	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 25V$ $f = 1.0\text{MHz}$	-	478	-	pF
C_{OSS}	Output Capacitance					
C_{RSS}	Reverse Transfer Capacitance					
Switching Characteristics						
$t_{d(ON)}$	Turn-on Delay Time	$V_{DD} = 30V, V_{GS} = 10V$ $R_G = 2.5\Omega, R_L = 15\Omega$ $I_D = 2A$	-	11	-	ns
t_r	Turn-on Rise Time					
$t_{d(OFF)}$	Turn-Off Delay Time					
t_f	Turn-Off Fall Time					
Q_G	Total Gate-Charge	$V_{DD} = 30V$ $V_{GS} = 10V$ $I_D = 3A$	-	14.1	-	nC
Q_{GS}	Gate to Source Charge					
Q_{GD}	Gate to Drain (Miller) Charge					
Source-Drain Diode Characteristics						
V_{SD}	Diode Forward Voltage ^{*2}	$I_{SD} = 1A, V_{GS} = 0V$	-	-	1.2	V
I_S	Diode Continuous Forward Current		-	-	10	A

Notes:

1. The data tested by surface mounted on a 1 inch² board with 2 OZ copper
2. The data tested by pulsed, pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
3. The power dissipation is limited by 150 °C Junction temperature

Ratings and Characteristics Curves (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

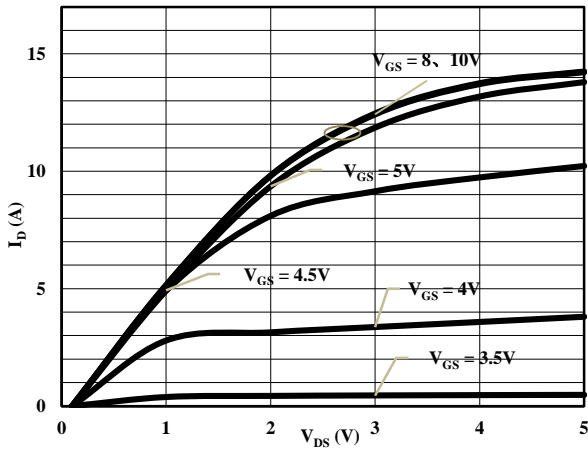


Fig 1 On-Region Characteristics

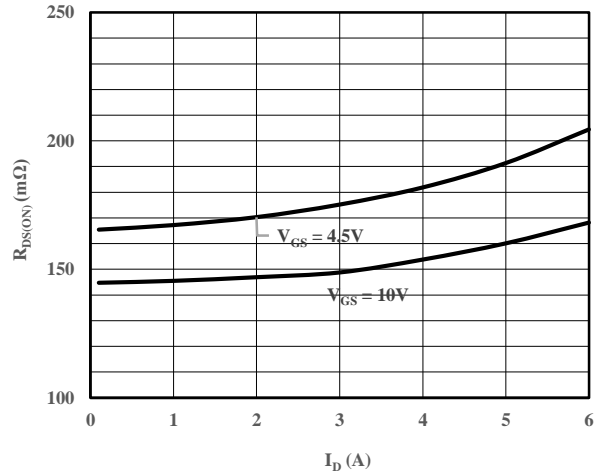


Fig 2 On-Resistance vs. Drain Current and Gate Voltage

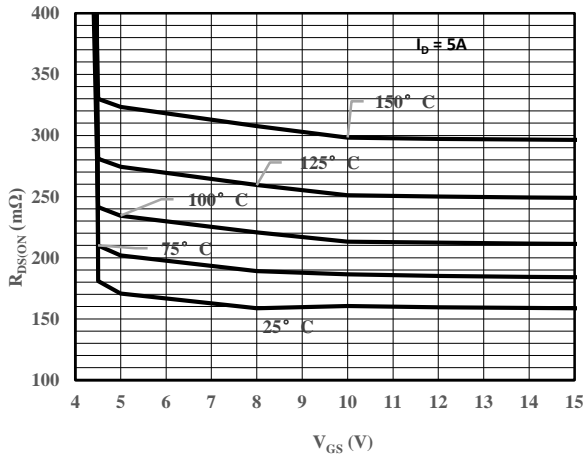


Fig 3 On-Resistance vs. Gate-Source Voltage

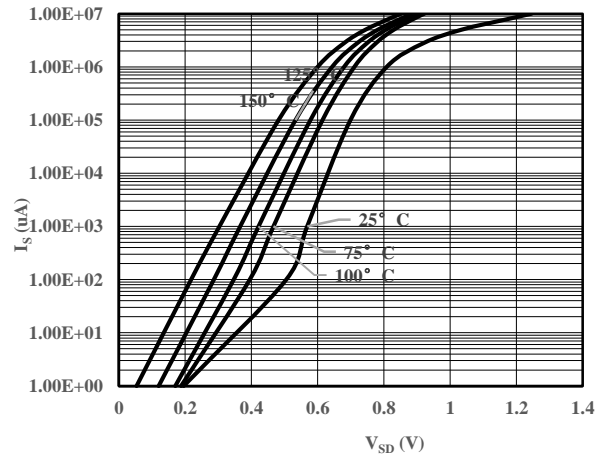


Fig 4 Body-Diode Characteristics

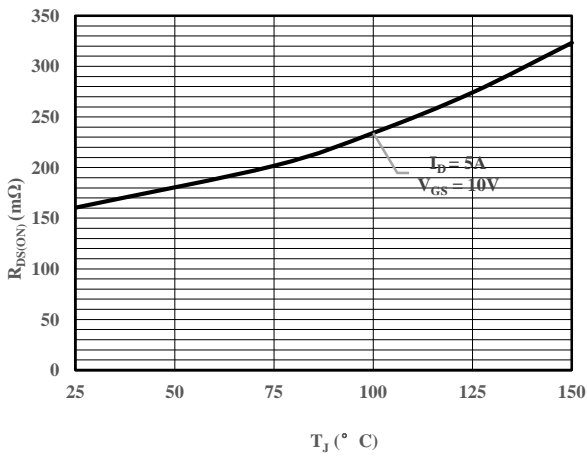


Fig 5 On-Resistance vs. Junction Temperature

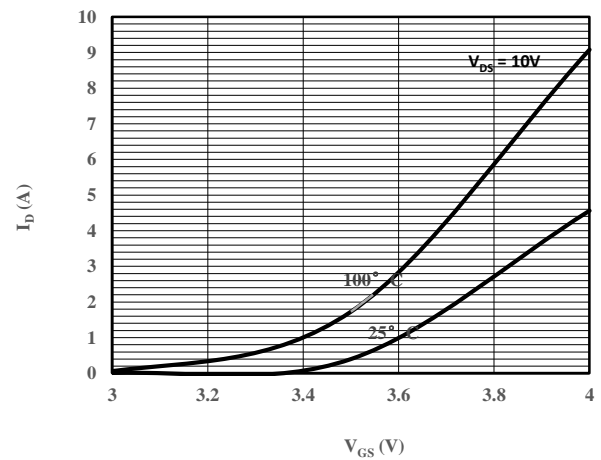


Fig 6 Transfer Characteristics

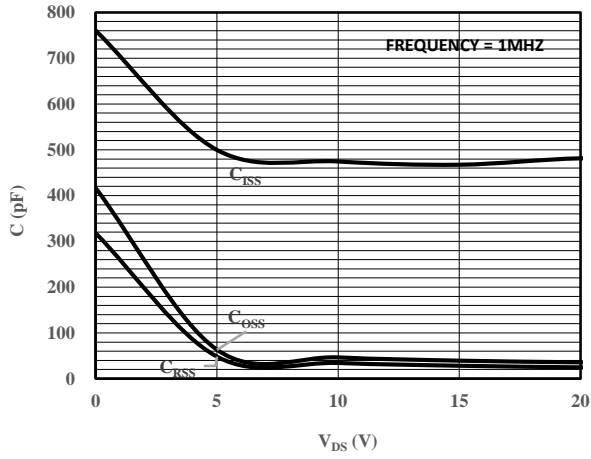


Fig 7 Capacitance Characteristics

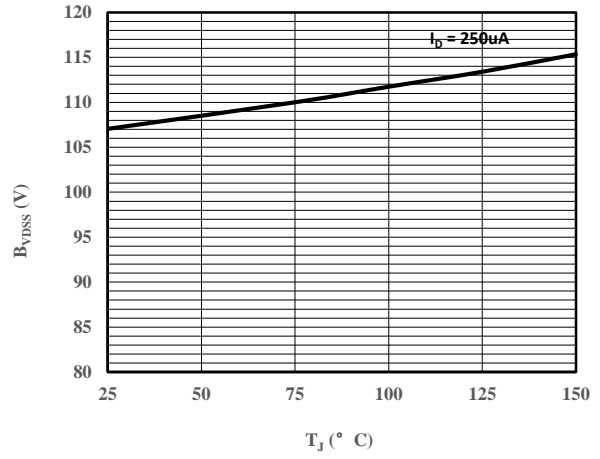


Fig 8 Drain-Source vs. Junction Temperature

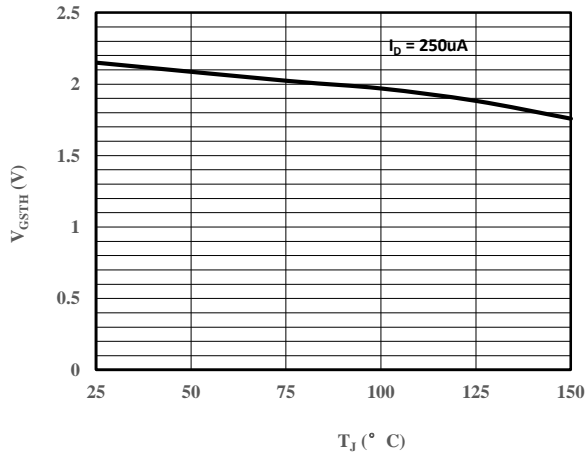
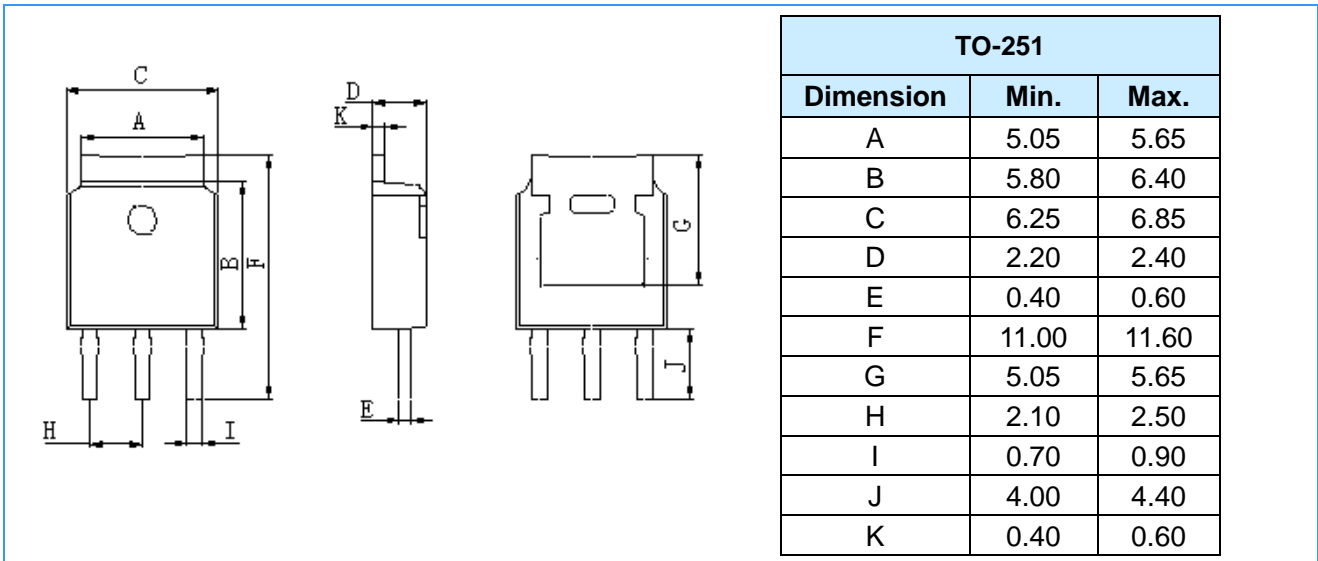


Fig 9 Gate Voltage vs. Junction Temperature

Package Outline Dimensions (Unit: mm)



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